Docket Number: 05–001. Applicant: California Department of Food and Agriculture, 3294 Meadowview Road, Sacramento, CA 95832.

Instrument: Electron Microscope, Model H–7500–1 TEM.

Manufacturer: Hitachi High Technologies Corporation.

Intended Use: The instrument is intended to be used to observe and to record images of plant viruses from crude plant sap, purified virus preparations and in imbedded plant tissues to study and identify new and emerging plant viruses that are important for California agriculture. Application accepted by Commissioner of Customs: January 5, 2005.

Gerald A. Zerdy,

Program Manager, Statutory Import Programs Staff.

[FR Doc. E5-540 Filed 2-8-05; 8:45 am]

DEPARTMENT OF COMMERCE

International Trade Administration

Virginia Commonwealth University, et al.; Notice of Consolidated Decision on Applications for Duty-Free Entry of Electron Microscopes

This is a decision consolidated pursuant to Section 6(c) of the Educational, Scientific, and Cultural Materials Importation Act of 1966 (Pub. L. 89–651, 80 Stat. 897; 15 CFR part 301). Related records can be viewed between 8:30 a.m. and 5 p.m. in Suite 4100W, Franklin Court Building, U.S. Department of Commerce, 1099 14th Street, NW., Washington, DC.

Docket Number: 04–022. Applicant: Virginia Commonwealth University, Richmond, VA. Instrument: Electron Microscope, Model JEM–1230. Manufacturer: JEOL, Ltd., Japan. Intended Use: See notice at 69 FR 77995, December 29, 2004. Order Date: January 29, 2004.

Docket Number: 04–023. Applicant: Oklahoma Medical Research Foundation, Oklahoma City, OK. Instrument: Electron Microscope, Model H–7600–1 TEM. Manufacturer: Hitachi, Ltd., Japan. Intended Use: See notice at 69 FR 7794, December 29, 2004. Order Date: December 11, 2003.

Docket Number: 04–024. Applicant: The University of Iowa, Iowa City, IA. Instrument: Electron Microscope, Model JEM–1230. Manufacturer: JEOL, Ltd., Japan. Intended Use: See notice at 66 FR 77994, December 29, 2004. Order Date: May 4, 2004.

Docket Number: 04–025. Applicant: Oak Ridge National Laboratory, Oak

Ridge, TN. Instrument: Electron Microscope, Model JEM–2200FS. Manufacturer: JEOL, Ltd., Japan. Intended Use: See notice at 66 FR 77995, December 29, 2004. Order Date: December 31, 2003.

Comments: None received. Decision: Approved. No instrument of equivalent scientific value to the foreign instrument, for such purposes as these instruments are intended to be used, was being manufactured in the United States at the time the instruments were ordered. Reasons: Each foreign instrument is a conventional transmission electron microscope (CTEM) and is intended for research or scientific educational uses requiring a CTEM. We know of no CTEM, or any other instrument suited to these purposes, which was being manufactured in the United States either at the time of order of each instrument or at the time of receipt of application by U.S. Customs and Border Protection.

Gerald A. Zerdy,

Program Manager, Statutory Import Programs Staff.

[FR Doc. E5–539 Filed 2–8–05; 8:45 am] BILLING CODE 3510–DS–P

DEPARTMENT OF COMMERCE

National Oceanic and Atmospheric Administration

[I.D. 020305B]

South Atlantic Fishery Management Council; Public Meetings

AGENCY: National Marine Fisheries Service (NMFS), National Oceanic and Atmospheric Administration (NOAA), Commerce.

ACTION: Notice of public meetings.

SUMMARY: The South Atlantic Fishery Management Council (Council) will hold meetings of its Snapper Grouper Committee, Advisory Panel Selection Committee, Joint Executive and Finance Committees, Controlled Access Committee, Highly Migratory Species Committee, and a meeting of the full Council. In addition, there will be a public scoping meeting addressing the Fishery Ecosystem Plan and Comprehensive Amendment.

DATES: The meeting will be held in February and March 2005. See **SUPPLEMENTARY INFORMATION** for specific dates and times.

ADDRESSES: The meeting will be held at the Hilton Savannah DeSoto Hotel, 15 East Liberty Street, Savannah, GA 31401 Telephone: (1–800) 426–8483 or 912/232–9000, FAX 912/232–6018.

Copies of documents are available from Kim Iverson, Public Information Officer, South Atlantic Fishery Management Council, One Southpark Circle, Suite 306, Charleston, SC 29407– 4699.

FOR FURTHER INFORMATION CONTACT: Kim Iverson, Public Information Officer; telephone: 843/571–4366 or toll free at 866/SAFMC–10; fax: 843/769–4520; email: kim.iverson@safmc.net.

SUPPLEMENTARY INFORMATION:

Meeting Dates

1. Snapper Grouper Committee Meeting: February 28, 2005, 1:30 p.m. – 5 p.m. and March 1, 2005, 8:30 a.m. – 5 p.m.

The Snapper Grouper Committee will review draft Amendment 13B regarding mandates under the Sustainable Fisheries Act to address overfishing and choose management measure alternatives. In addition, the Committee will review and develop recommendations for the "Oculina Closed Area Evaluation Plan", receive an update on the Large Whale Take Reduction Team Draft Environmental Impact Statement (DEIS) and Proposed Rule, and receive a presentation by NOAA Fisheries' Southeast Regional Office on linking permits and landings databases.

Note: A public scoping meeting on the Fishery Ecosystem Plan and Comprehensive Amendment will be held February 28, 2005 beginning at 6 p.m.

2. Advisory Panel Selection Committee Meeting: March 2, 2005, 8:30 a.m. – 10 a.m. (CLOSED SESSION)

The Committee will review advisory panel applications and develop recommendations for Council consideration.

3. Joint Executive Committee and Finance Committee Meeting: March 2, 2005, 10 a.m. until 12 noon

The Committees will receive an update on additional Calendar Year (CY) 2005 funds and review the CY 2005 activities schedule. The Committees will also review activities and budgets for Ecosystem-based management, the Southeast Data, Assessment, and Review (SEDAR) stock assessment process, and Coral activities, and receive a report on the status of the CY 2005–2009 grant budget.

4. Controlled Access Committee Meeting: March 2, 2005, 1:30 p.m. – 5 p.m.

The Controlled Access Committee will receive an introduction to rightsbased systems, discuss Individual